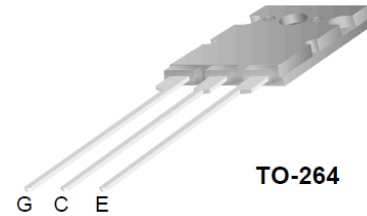


## IGBT

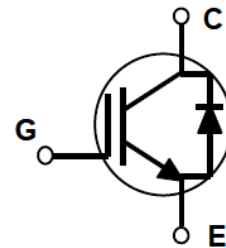
### Features

- 600V,80A
- $V_{CE(sat)(typ.)} = 1.55V @ V_{GE} = 15V, I_C = 80A$
- High speed switching
- Higher system efficiency
- Soft current turn-off waveforms



### General Description

JIAEN Trench IGBTs offer lower losses and higher energy efficiency for application such as induction heating, UPS, AC & DC motor controls and general purpose inverter .



### Absolute Maximum Ratings

Symbol	Parameter	Value	Units
$V_{CES}$	Collector-Emitter Voltage	600	V
$V_{GES}$	Gate-Emitter Voltage	$\pm 30$	V
$I_C$	Continuous Collector Current ( $T_C=25^\circ C$ )	120	A
	Continuous Collector Current ( $T_C=100^\circ C$ )	80	A
$I_{CM}$	Pulsed Collector Current (Note 1)	240	A
$I_F$	Diode Continuous Forward Current ( $T_C=100^\circ C$ )	80	A
$I_{FM}$	Diode Maximum Forward Current (Note 1)	250	A
$t_{sc}$	Short Circuit Withstand Time	10	us
$P_D$	Maximum Power Dissipation ( $T_C=25^\circ C$ )	500	W
	Maximum Power Dissipation ( $T_C=100^\circ C$ )	200	W
$T_J$	Operating Junction Temperature Range	-40 to +150	$^\circ C$
$T_{STG}$	Storage Temperature Range	-55 to +150	$^\circ C$

### Thermal Characteristics

Symbol	Parameter	Max.	Units
$R_{th\ j-c}$	Thermal Resistance, Junction to case for IGBT	0.25	$^\circ C / W$
$R_{th\ j-c}$	Thermal Resistance, Junction to case for Diode	0.5	$^\circ C / W$
$R_{th\ j-a}$	Thermal Resistance, Junction to Ambient	25	$\square / W$

**Electrical Characteristics** ( $T_C=25^\circ\text{C}$  unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units	
$BV_{CES}$	Collector-Emitter Breakdown Voltage	$V_{GE}=0V, I_C=250\mu A$	600	-	-	V	
$I_{CES}$	Collector-Emitter Leakage Current	$V_{CE}=600V, V_{GE}=0V$	-	-	100	$\mu A$	
$I_{GES}$	Gate Leakage Current, Forward	$V_{GE}=30V, V_{CE}=0V$	-	-	100	nA	
	Gate Leakage Current, Reverse	$V_{GE}=-30V, V_{CE}=0V$	-	-	-100	nA	
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE}=V_{CE}, I_C=250\mu A$	4.5	-	6.5	V	
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$V_{GE}=15V, I_C=80A$	-	1.55	2.15	V	
		$V_{GE}=15V, I_C=80A$ $T_C=125^\circ\text{C}$		1.7			
		$V_{GE}=15V, I_C=120A$		2.1			
$t_{d(on)}$	Turn-on Delay Time	$V_{CC}=400V$ $V_{GE}=15V$ $I_C=80A$ $R_G=10\Omega$ Inductive Load $T_C=25^\circ\text{C}$	-	208	-	ns	
$t_r$	Turn-on Rise Time		-	548	-	ns	
$t_{d(off)}$	Turn-off Delay Time		-	136	-	ns	
$t_f$	Turn-off Fall Time		-	184	-	ns	
Eon	Turn-on Switching Loss		-	15.8	-	mJ	
Eoff	Turn-off Switching Loss		-	3.2	-	mJ	
Ets	Total Switching Loss		-	19	-	mJ	
$t_{d(on)}$	Turn-on Delay Time		$V_{CC}=400V$ $V_{GE}=15V$ $I_C=80A$ $R_G=10\Omega$ Inductive Load $T_C=125^\circ\text{C}$	-	188	-	ns
$t_r$	Turn-on Rise Time			-	406	-	ns
$t_{d(off)}$	Turn-off Delay Time			-	164	-	ns
$t_f$	Turn-off Fall Time	-		264	-	ns	
Eon	Turn-on Switching Loss	-		11.7	-	mJ	
Eoff	Turn-off Switching Loss	-		4.2	-	mJ	
Ets	Total Switching Loss	-		15.9	-	mJ	
$C_{ies}$	Input Capacitance	$V_{CE}=30V$		-	7090	-	pF
$C_{oes}$	Output Capacitance	$V_{GE}=0V$	-	470	-	pF	
$C_{res}$	Reverse Transfer Capacitance	$f=1\text{MHz}$	-	60	-	pF	
Qg	Total Gate Charge	$V_{CC}=300V$ $V_{GE}=15V$ $I_C=80A$	-	300		nC	
Qge	Gate-Emitter Charge		-	105		nC	
Qgc	Gate-Collector Charge		-	175		nC	

**Electrical Characteristics of Diode** ( $T_C=25^\circ\text{C}$  unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
$V_F$	Diode Forward Voltage	$I_F=80A$	-	1.5	2.1	V

$t_{rr}$	Diode Reverse Recovery Time	$V_{CE} = 400V$	-	85		ns
$I_{rr}$	Diode peak Reverse Recovery Current	$I_F = 80A$	-	6.5		A
$Q_{rr}$	Diode Reverse Recovery Charge	$dI_F/dt = 200A/us$	-	290		nC

**Notes:**

1. Repetitive Rating: Pulse width limited by maximum junction temperature

## Typical Performance Characteristics

Figure 1. Typical Output Characteristics

$T_c=25^\circ\text{C}$

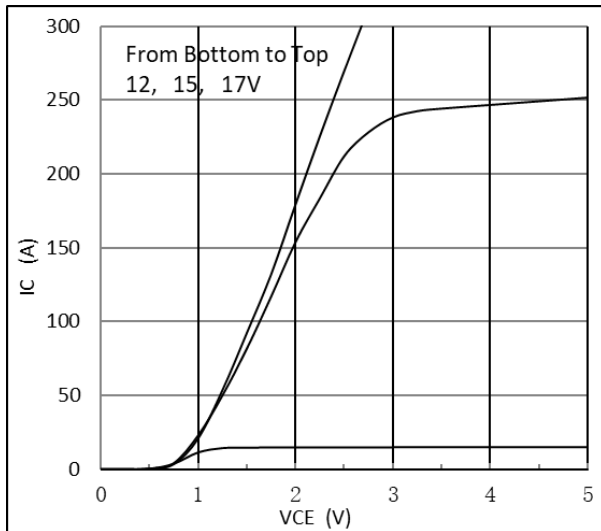


Figure 2. Typical Saturation Voltage Characteristics  $V_G=15\text{V}$

Characteristics  $V_G=15\text{V}$

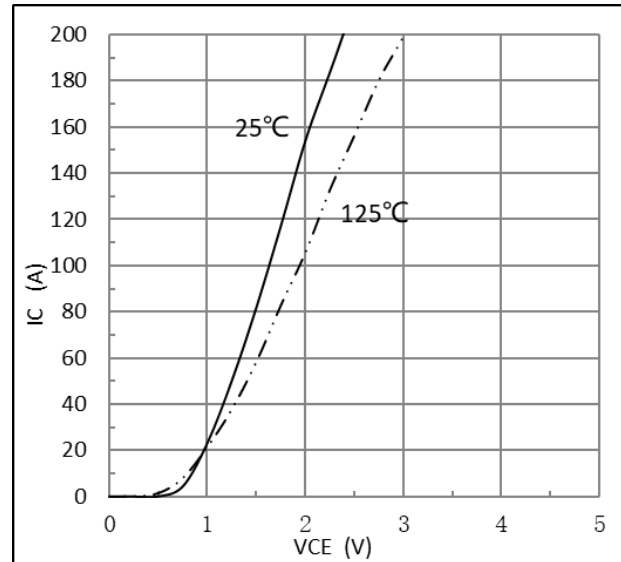


Figure 3. Saturation Voltage vs. Case Temperature at Variant Current Level

$V_{ge}=15\text{V}$

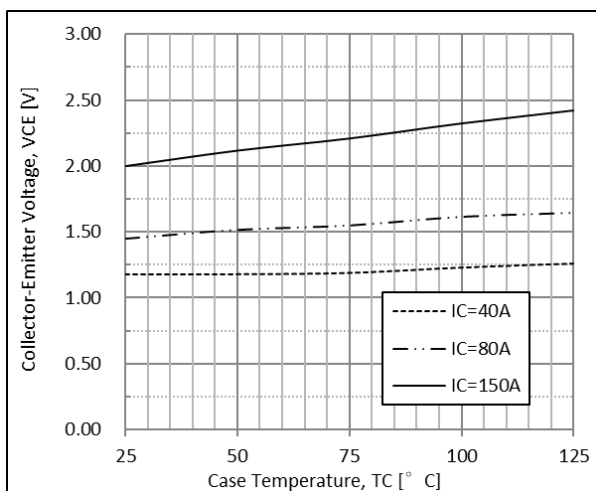


Figure 4. Forward Characteristics

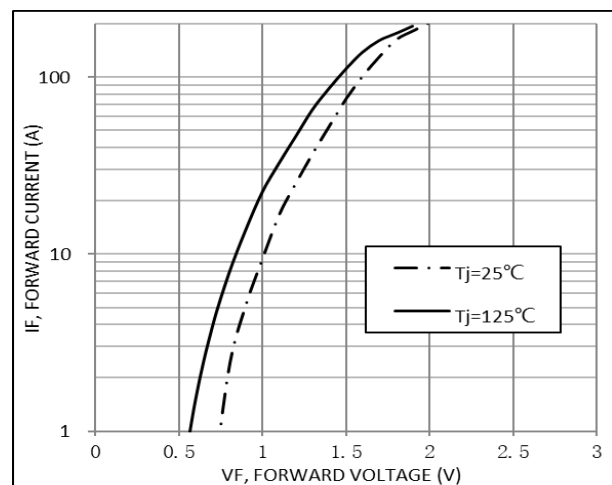


Figure 5. Saturation Voltage vs. VGE

Tc=25C

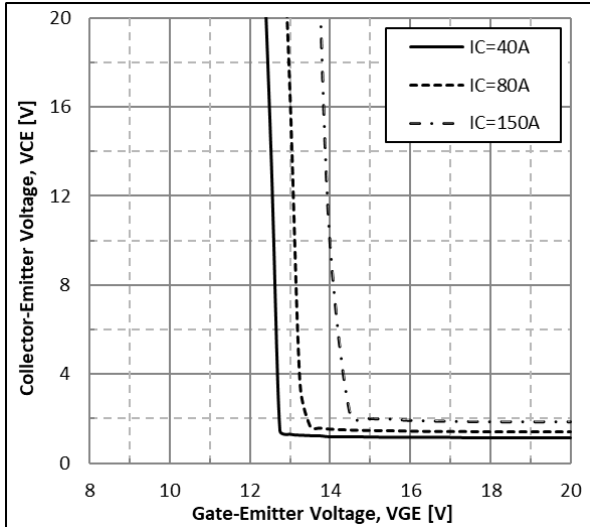


Figure 6. Saturation Voltage vs. VGE

Tc=125C

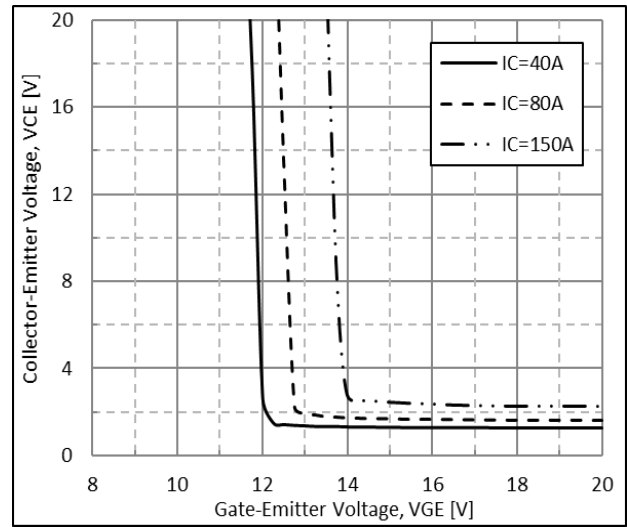


Figure 7. Switching Loss vs. Gate Resistance

(VCC=400V, VGE= ±15V, IC=80A)

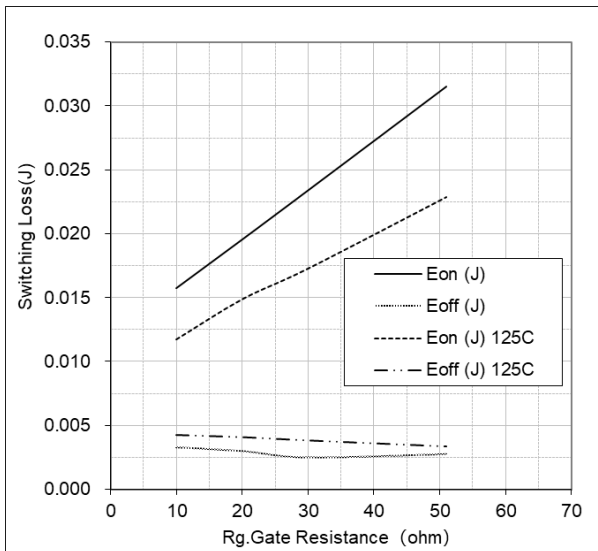
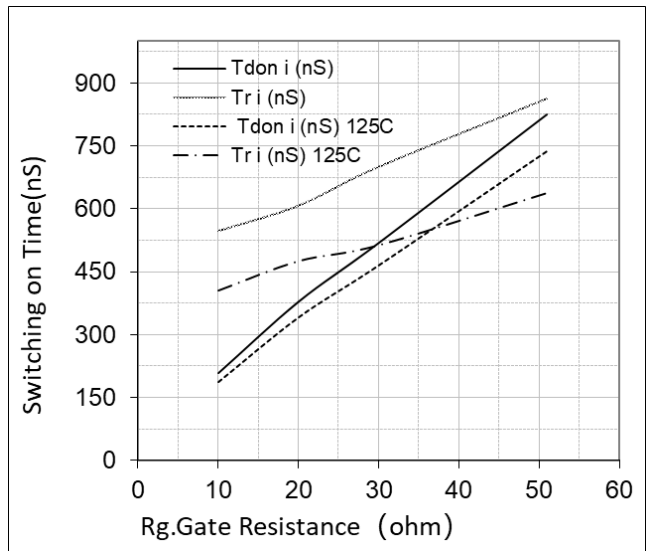
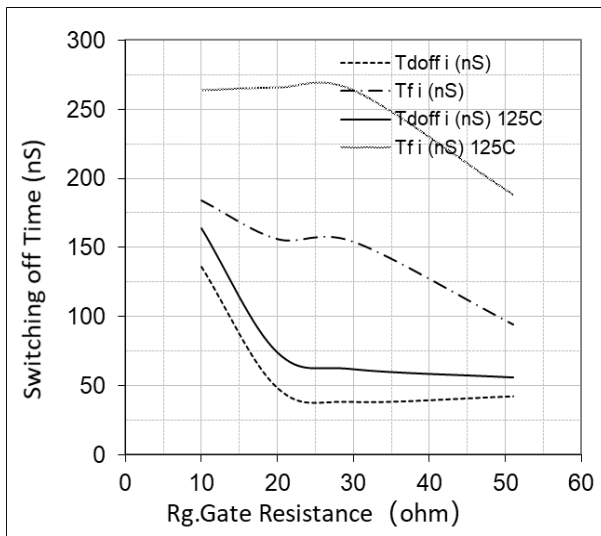


Figure 8. Turn-On Characteristics vs. Gate Resistance

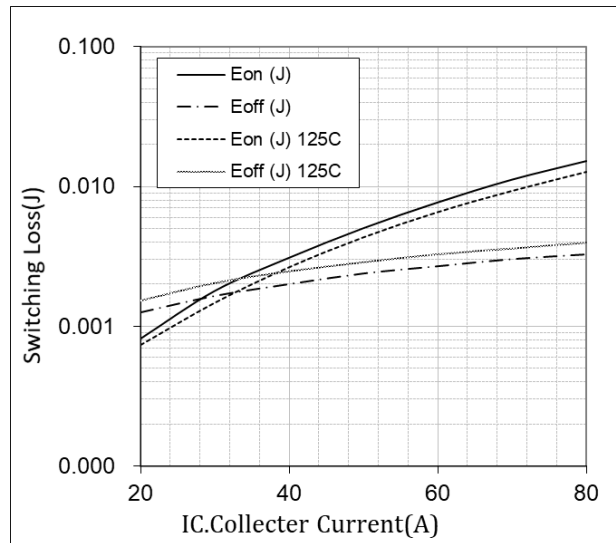
(VCC=400V, VGE= ±15V, IC=80A,)



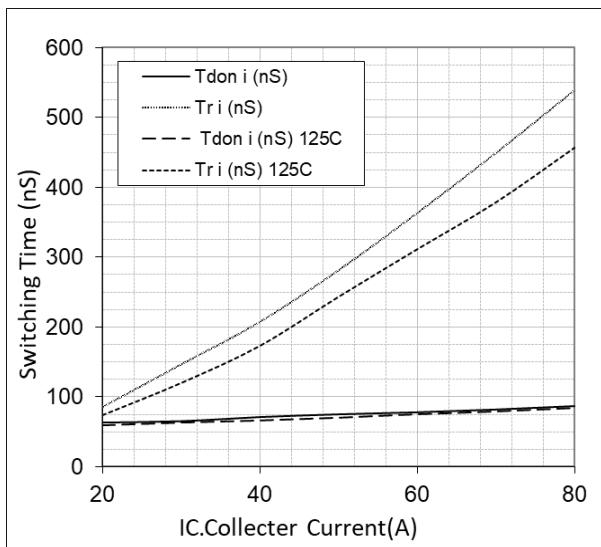
**Figure 9. Turn-Off Characteristics vs. Gate Resistance** (VCC=400V, VGE=±15V, IC=80A,)



**Figure 10. Switching Loss vs. Collector Current** (VGE=±15V, RG=5 OHM, VCC=400V)



**Figure 11. Turn-On Characteristics vs. Collector Current** (VGE=±15V, RG=5 OHM, VCC=400V)



**Figure 12. Turn-Off Characteristics vs. Collector Current** (VGE=±15V, RG=5 OHM, VCC=400V)

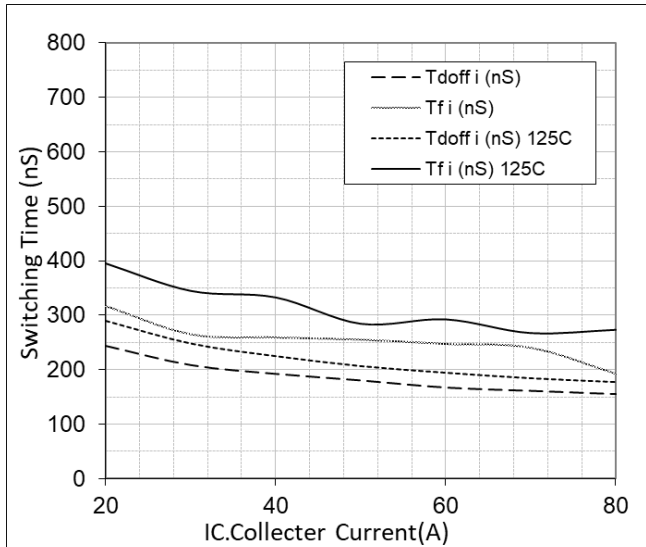


Figure 13. Gate Charge Characteristics

RL=10 ohm TC=25C IC=80A

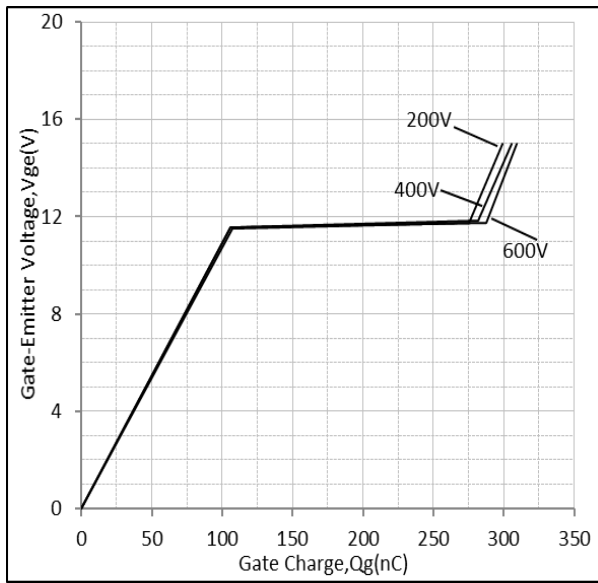


Figure 14. Reverse Recovery Current

VCC=400V, RG=10 ohm, VG=±15V IL=500uH

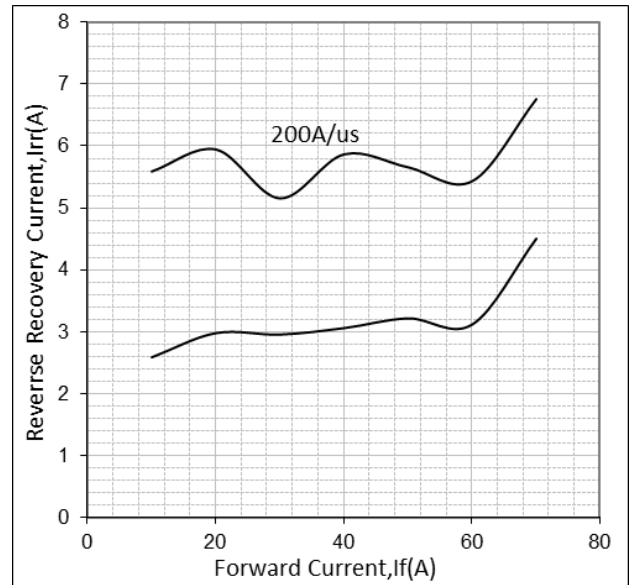


Figure 15. Stored Charge

VCC=400V, RG=10 ohm, VG=±15V IL=500uH

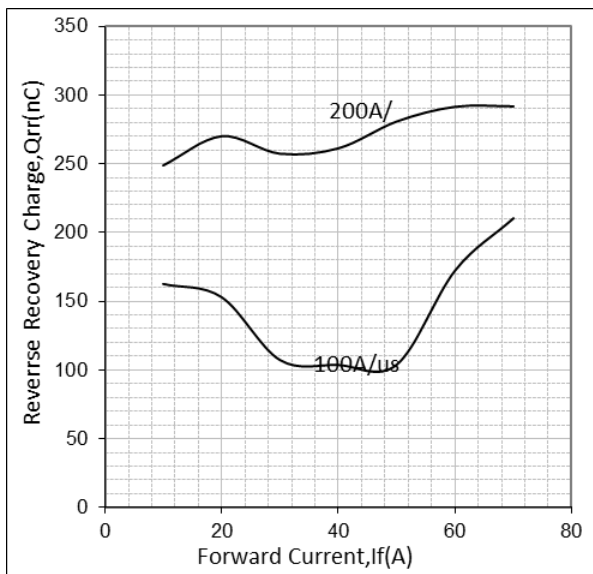


Figure 16. Reverse Recovery Time

VCC=400V, RG=10 ohm, VG=±15V IL=500uH

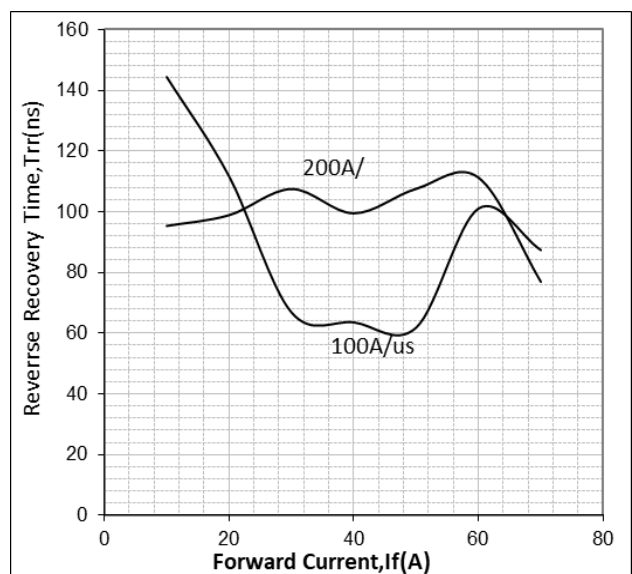


Figure 17. SOA Characteristics

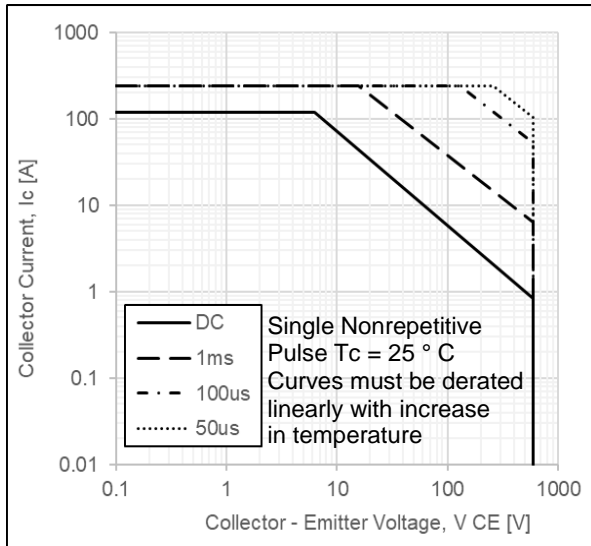


Figure 18. Turn Off SOA

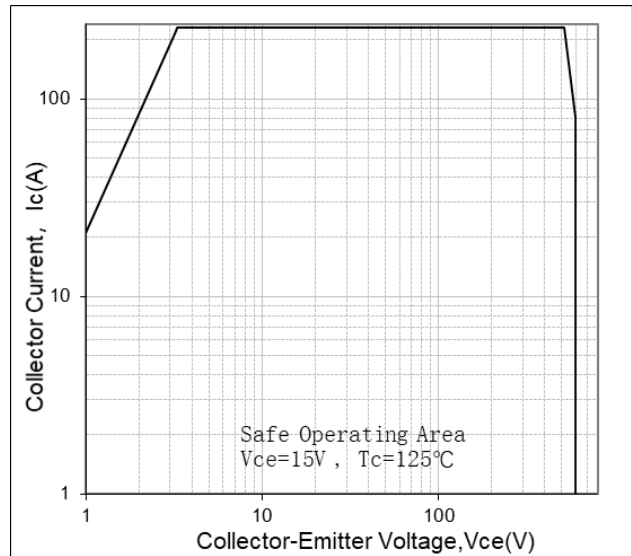


Figure 19. Capacitance Characteristics

Common Emitter,  $V_{GE} = 0V$ ,  $f = 1MHz$ ,  $T_C = 25^\circ C$

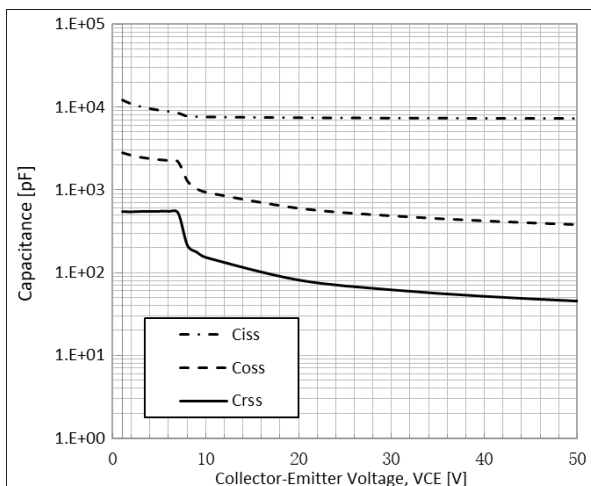
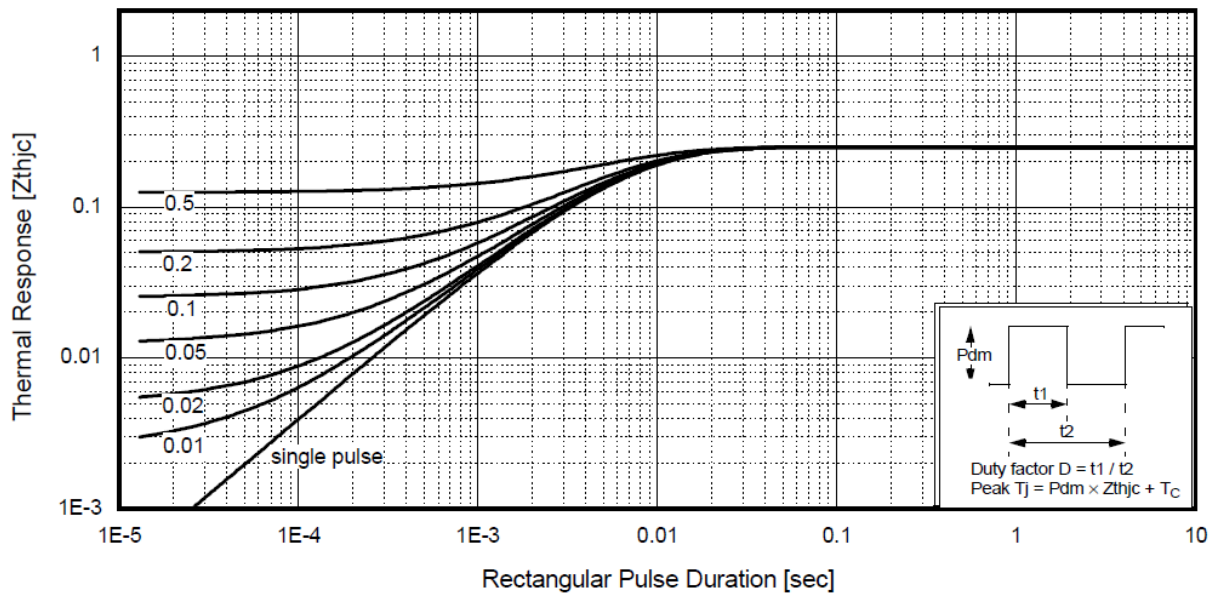


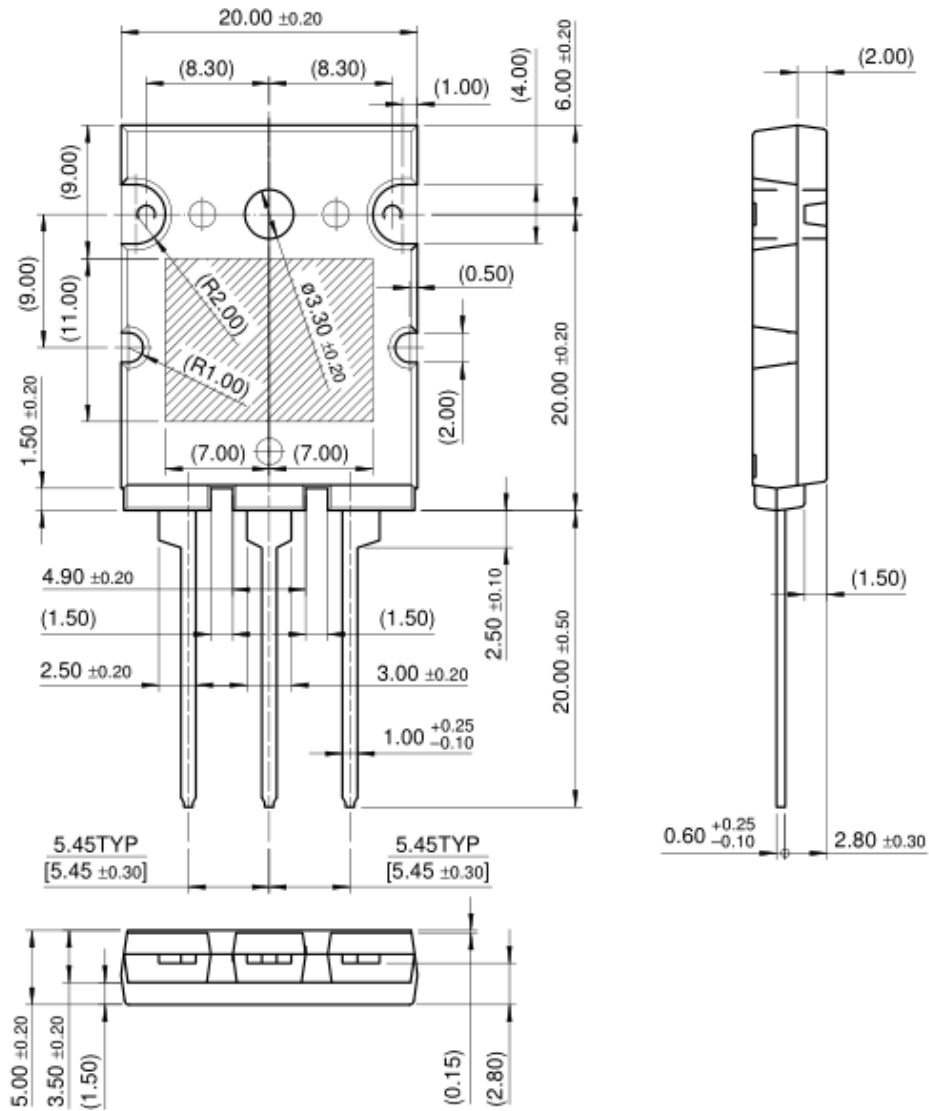


Figure 20. Transient Thermal Impedance of IGBT



Mechanical Dimensions

TO-264



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